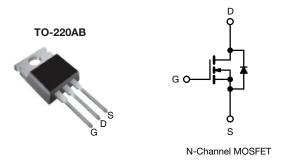
## IRF840LC

**Vishay Siliconix** 

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### Power MOSFET



PRODUCT SUMMARY				
V <sub>DS</sub> (V)	500			
R <sub>DS(on)</sub> (Ω)	$V_{GS} = 10 V$	0.85		
Q <sub>g</sub> max. (nC)	39			
Q <sub>gs</sub> (nC)	10			
Q <sub>gd</sub> (nC)	19			
Configuration	Single			

#### **FEATURES**

- Ultra low gate charge
- · Reduced gate drive requirement
- Enhanced 30 V V<sub>GS</sub> rating
- Reduced C<sub>iss</sub>, C<sub>oss</sub>, C<sub>rss</sub>
- Extremely high frequency operation
- Repetitive avalanche rated
- Material categorization: for definitions of compliance please see <u>www.vishav.com/doc?99912</u>

#### Note

This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

#### DESCRIPTION

This new series of low charge power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing the new LCDMOS technology, the device improvements are achieved without added product cost, allowing for reduced gate drive requirements and total system savings. In addition, reduced switching losses and improved efficiency are achievable in a variety of high frequency applications. Frequencies of a few MHz at high current are possible using the new low charge MOSFETs.

These device improvements combined with the proven ruggedness and reliability that are characteristic of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF840LCPbF		
Lead (Pb)-free and halogen-free	IRF840LCPbF-BE3		

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V <sub>DS</sub>	500	- V	
Gate-source voltage			V <sub>GS</sub>	± 30		
Continuous drain current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C T <sub>C</sub> = 100 °C		8.0		
		T <sub>C</sub> = 100 °C	I <sub>D</sub>	5.1	А	
Pulsed drain current <sup>a</sup>			I <sub>DM</sub>	28		
Linear derating factor				1.0	W/°C	
Single pulse avalanche energy <sup>b</sup>			E <sub>AS</sub>	510	mJ	
Repetitive avalanche current <sup>a</sup>			I <sub>AR</sub>	8.0	А	
Repetitive avalanche energy <sup>a</sup>			E <sub>AR</sub>	13	mJ	
Maximum power dissipation	T <sub>C</sub> = 25 °C		PD	125	W	
Peak diode recovery dV/dt <sup>c</sup>			dV/dt	3.5	V/ns	
Operating junction and storage temperature range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Soldering recommendations (peak temperature) <sup>d</sup>	For 10 s			300		
Mounting torque	6-32 or M3 screw			10	lbf ∙ in	
Mounting torque				1.1	N · m	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b.  $V_{DD} = 50$  V, starting  $T_J = 25$  °C, L = 14 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 8.0$  A (see fig. 12)

c. 
$$I_{SD} \le 8.0$$
 A, dl/dt  $\le 100$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C

d. 1.6 mm from case

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R <sub>thJA</sub>	-	62		
Case-to-sink, flat, greased surface	R <sub>thCS</sub>	0.50	-	°C/W	
Maximum junction-to-case (drain)	R <sub>thJC</sub>	-	1.0		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static		•		•	•	•	•	
Drain-source breakdown voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = 250 \mu A$		500	-	-	V	
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	Referenc	Reference to 25 °C, I <sub>D</sub> = 1 mA		0.63	-	V/°C	
Gate-source threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$		-	4.0	V	
Gate-source leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20 \text{ V}$		-	± 100	nA	
		V <sub>DS</sub> =	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		-	25		
Zero gate voltage drain current	I <sub>DSS</sub>	$V_{DS} = 400V$	, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA	
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 4.8 A <sup>b</sup>	-	-	0.85	Ω	
Forward transconductance	9 <sub>fs</sub>	$V_{DS} = 50 \text{ V}, \text{ I}_{D} = 4.8 \text{ A}^{\text{b}}$		4.0	-	-	S	
Dynamic		•						
Drain-source breakdown voltage	C <sub>iss</sub>	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5		-	1100	-	pF	
V <sub>DS</sub> temperature coefficient	C <sub>oss</sub>			-	170	-		
Gate-source threshold voltage	C <sub>rss</sub>			-	18	-		
Gate-source leakage	Qg	V <sub>GS</sub> = 10 V I <sub>D</sub> = 8.0 A, V <sub>DS</sub> = 400 V see fig. 6 and 13 <sup>b</sup>		-	-	39		
Zene ante colte de alusia sumont	Q <sub>gs</sub>		-	-	10	nC		
Zero gate voltage drain current	Rain current Q <sub>gd</sub>		-	-	19			
Drain-source on-state resistance	t <sub>d(on)</sub>	$V_{DD} = 250 \text{ V, } I_D = 8.0 \text{ A,} \\ R_g = 9.1 \Omega, R_D = 30 \Omega \\ \text{see fig. 10}^{\text{b}}$		-	12	-	- ns	
Forward transconductance	t <sub>r</sub>			-	25	-		
Drain-source breakdown voltage	t <sub>d(off)</sub>			-	27	-		
V <sub>DS</sub> temperature coefficient	t <sub>f</sub>			-	19	-		
Gate input resistance	Rg	f = 1 MHz, open drain		0.7	-	3.7	Ω	
Internal drain inductance	L <sub>D</sub>	6 mm (0.25	Between lead, 6 mm (0.25") from		4.5	-		
Internal source inductance	L <sub>S</sub>	package and center of die contact		-	7.5	-	nH	
Drain-Source Body Diode Characteristic	s							
Continuous source-drain diode current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	8.0		
Pulsed diode forward current <sup>a</sup>	I <sub>SM</sub>			-	-	28	A	
Body diode voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 8.0 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	2.0	V	
Body diode reverse recovery time	t <sub>rr</sub>	T.=	25 °C, I <sub>F</sub> = 8.0 A,	-	490	740	ns	
Body diode reverse recovery charge	Q <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 8.0 A, dl/dt = 100 A/μs <sup>b</sup>		-	3.0	4.5	μC	
Forward turn-on time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is do			ninated b	by $L_{S}$ and	L <sub>D</sub> )	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %

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# IRF840LC

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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

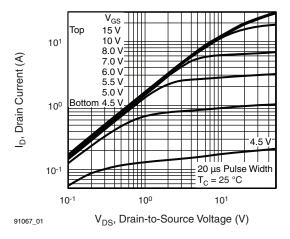


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

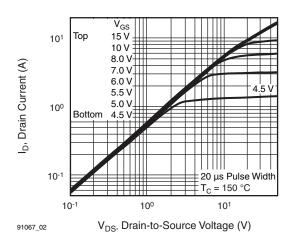


Fig. 2 - Typical Output Characteristics,  $T_C = 150 \ ^\circ C$ 

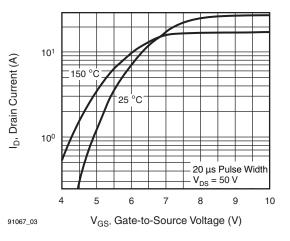


Fig. 3 - Typical Transfer Characteristics

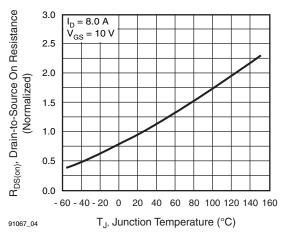


Fig. 4 - Normalized On-Resistance vs. Temperature

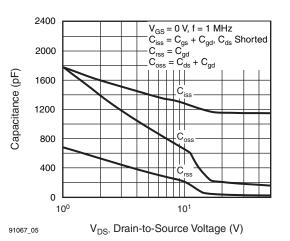


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

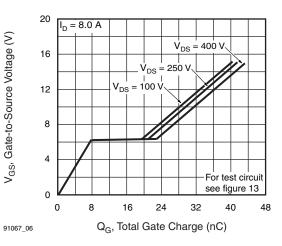


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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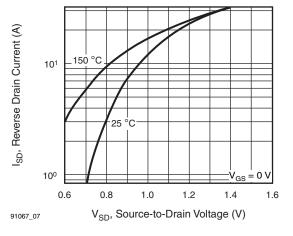


Fig. 7 - Typical Source-Drain Diode Forward Voltage

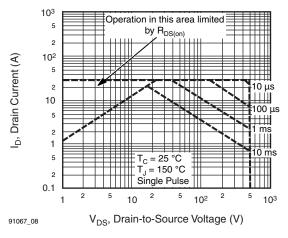


Fig. 8 - Maximum Safe Operating Area

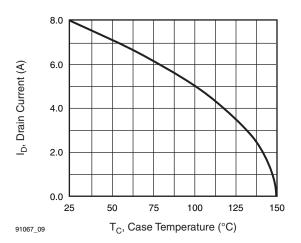


Fig. 9 - Maximum Drain Current vs. Case Temperature

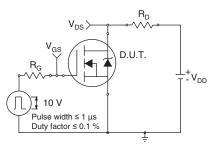


Fig. 10a - Switching Time Test Circuit

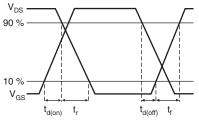
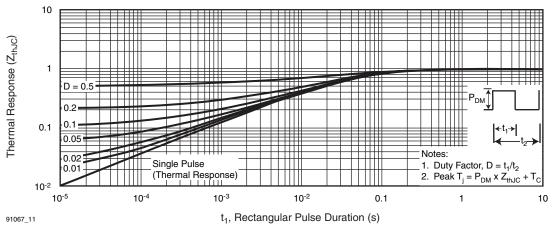


Fig. 10b - Switching Time Waveforms





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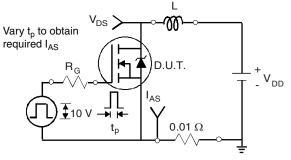


Fig. 12a - Unclamped Inductive Test Circuit

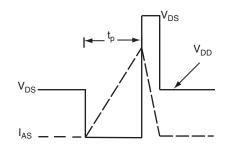


Fig. 12b - Unclamped Inductive Waveforms

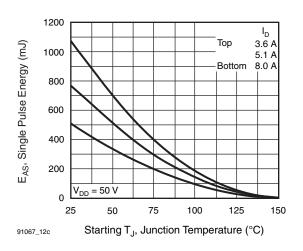


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

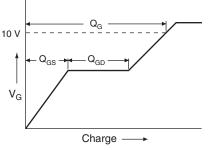


Fig. 13a - Basic Gate Charge Waveform

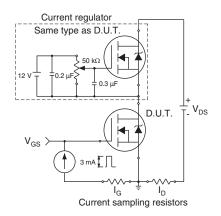


Fig. 13b - Gate Charge Test Circuit

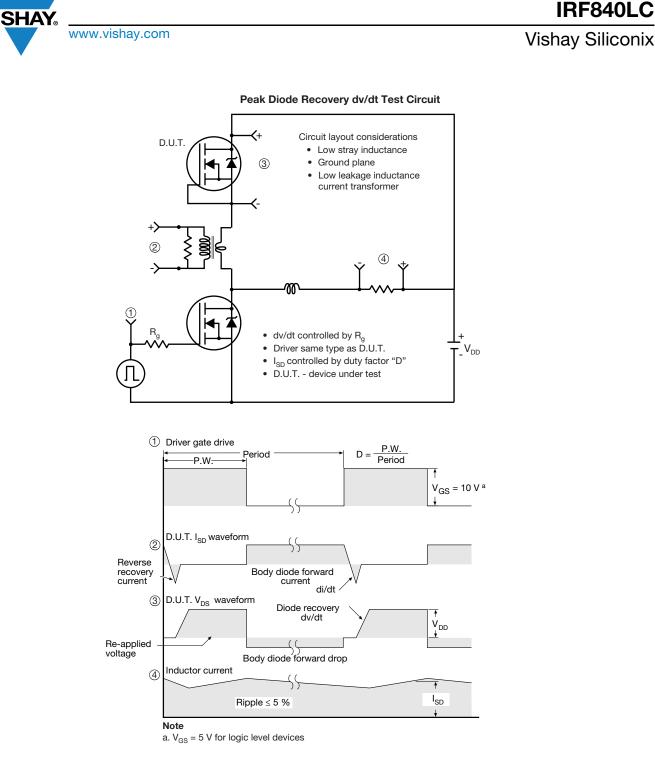


Fig. 14 - For N-Channel

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